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Intel - 5SGXMA4H2F35I3LN Datasheet



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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| Details | |
|--------------------------------|---|
| Product Status | Obsolete |
| Number of LABs/CLBs | 158500 |
| Number of Logic Elements/Cells | 420000 |
| Total RAM Bits | 37888000 |
| Number of I/O | 600 |
| Number of Gates | - |
| Voltage - Supply | 0.82V ~ 0.88V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 100°C (TJ) |
| Package / Case | 1152-BBGA, FCBGA |
| Supplier Device Package | 1152-FBGA (35x35) |
| Purchase URL | https://www.e-xfl.com/product-detail/intel/5sgxma4h2f35i3ln |
| | |

Email: info@E-XFL.COM

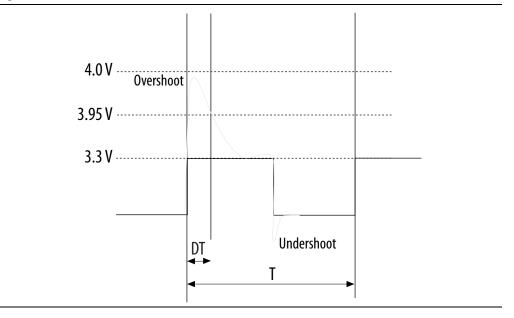
Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Table 5 lists the maximum allowed input overshoot voltage and the duration of the overshoot voltage as a percentage of device lifetime. The maximum allowed overshoot duration is specified as a percentage of high time over the lifetime of the device. A DC signal is equivalent to 100% of the duty cycle. For example, a signal that overshoots to 3.95 V can be at 3.95 V for only ~21% over the lifetime of the device; for a device lifetime of 10 years, the overshoot duration amounts to ~2 years.

| Table 5. Maximum Anowed Overshoot During Transitions | | | | | | | |
|--|------------------|---------------|---|------|--|--|--|
| Symbol | Description | Condition (V) | Overshoot Duration as % @ T _J = 100°C | Unit | | | |
| | | 3.8 | 100 | % | | | |
| | | 3.85 | 64 | % | | | |
| | | 3.9 | 36 | % | | | |
| | | 3.95 | 21 | % | | | |
| Vi (AC) | AC input voltage | 4 | 12 | % | | | |
| | | 4.05 | 7 | % | | | |
| | | 4.1 | 4 | % | | | |
| | | 4.15 | 2 | % | | | |
| | | 4.2 | 1 | % | | | |

Table 5. Maximum Allowed Overshoot During Transitions

Figure 1. Stratix V Device Overshoot Duration



This section lists the functional operating limits for the AC and DC parameters for Stratix V devices. Table 6 lists the steady-state voltage and current values expected from Stratix V devices. Power supply ramps must all be strictly monotonic, without plateaus.

Table 6. Recommended Operating Conditions for Stratix V Devices (Part 1 of 2)

| Symbol | Description | Condition | Min ⁽⁴⁾ | Тур | Max ⁽⁴⁾ | Unit |
|----------------------------------|---|------------|--------------------|------|--------------------|------|
| | Core voltage and periphery circuitry power supply (C1, C2, I2, and I3YY speed grades) | _ | 0.87 | 0.9 | 0.93 | V |
| V _{CC} | Core voltage and periphery circuitry power supply (C2L, C3, C4, I2L, I3, I3L, and I4 speed grades) ⁽³⁾ | _ | 0.82 | 0.85 | 0.88 | V |
| V _{CCPT} | Power supply for programmable power technology | _ | 1.45 | 1.50 | 1.55 | V |
| V _{CC_AUX} | Auxiliary supply for the programmable power technology | _ | 2.375 | 2.5 | 2.625 | V |
| VI (1) | I/O pre-driver (3.0 V) power supply | _ | 2.85 | 3.0 | 3.15 | V |
| V _{CCPD} ⁽¹⁾ | I/O pre-driver (2.5 V) power supply | _ | 2.375 | 2.5 | 2.625 | V |
| | I/O buffers (3.0 V) power supply | | 2.85 | 3.0 | 3.15 | V |
| | I/O buffers (2.5 V) power supply | _ | 2.375 | 2.5 | 2.625 | V |
| | I/O buffers (1.8 V) power supply | | 1.71 | 1.8 | 1.89 | V |
| V _{CCIO} | I/O buffers (1.5 V) power supply | _ | 1.425 | 1.5 | 1.575 | V |
| | I/O buffers (1.35 V) power supply | _ | 1.283 | 1.35 | 1.45 | V |
| | I/O buffers (1.25 V) power supply | _ | 1.19 | 1.25 | 1.31 | V |
| | I/O buffers (1.2 V) power supply | _ | 1.14 | 1.2 | 1.26 | V |
| | Configuration pins (3.0 V) power supply | _ | 2.85 | 3.0 | 3.15 | V |
| V _{CCPGM} | Configuration pins (2.5 V) power supply | _ | 2.375 | 2.5 | 2.625 | V |
| | Configuration pins (1.8 V) power supply | _ | 1.71 | 1.8 | 1.89 | V |
| V _{CCA_FPLL} | PLL analog voltage regulator power supply | _ | 2.375 | 2.5 | 2.625 | V |
| V _{CCD_FPLL} | PLL digital voltage regulator power supply | _ | 1.45 | 1.5 | 1.55 | V |
| V _{CCBAT} (2) | Batteny back-up nower supply (For design | | 1.2 | _ | 3.0 | V |
| VI | DC input voltage | _ | -0.5 | _ | 3.6 | V |
| V ₀ | Output voltage | — | 0 | — | V _{CCIO} | V |
| т | Operating junction temperature | Commercial | 0 | — | 85 | °C |
| TJ | Operating junction temperature | Industrial | -40 | _ | 100 | °C |

Table 8 shows the transceiver power supply voltage requirements for various conditions.

Table 8. Transceiver Power Supply Voltage Requirements

| Conditions | Core Speed Grade | VCCR_GXB & VCCT_GXB ⁽²⁾ | VCCA_GXB | VCCH_GXB | Unit |
|---|-----------------------------------|---------------------------------------|----------|----------|------|
| If BOTH of the following conditions are true: | All | 1.05 | | | |
| Data rate > 10.3 Gbps. DFE is used. | All | 1.05 | | | |
| If ANY of the following conditions are true ⁽¹⁾ : | | | 3.0 | | |
| ATX PLL is used. | | | | | |
| ■ Data rate > 6.5Gbps. | All | 1.0 | | | |
| ■ DFE (data rate ≤ 10.3 Gbps), AEQ, or EyeQ feature is used. | | | | 1.5 | V |
| If ALL of the following | C1, C2, I2, and I3YY | 0.90 | 2.5 | | |
| conditions are true:ATX PLL is not used. | | | | | |
| ■ Data rate ≤ 6.5Gbps. | C2L, C3, C4, I2L, I3, I3L, and I4 | 0.85 | 2.5 | | |
| DFE, AEQ, and EyeQ are not used. | | | | | |

Notes to Table 8:

(1) Choose this power supply voltage requirement option if you plan to upgrade your design later with any of the listed conditions.

(2) If the VCCR_GXB and VCCT_GXB supplies are set to 1.0 V or 1.05 V, they cannot be shared with the VCC core supply. If the VCCR_GXB and VCCT_GXB are set to either 0.90 V or 0.85 V, they can be shared with the VCC core supply.

DC Characteristics

This section lists the supply current, I/O pin leakage current, input pin capacitance, on-chip termination tolerance, and hot socketing specifications.

Supply Current

Supply current is the current drawn from the respective power rails used for power budgeting. Use the Excel-based Early Power Estimator (EPE) to get supply current estimates for your design because these currents vary greatly with the resources you use.

For more information about power estimation tools, refer to the *PowerPlay Early Power Estimator User Guide* and the *PowerPlay Power Analysis* chapter in the *Quartus II Handbook*.

I/O Pin Leakage Current

Table 9 lists the Stratix V I/O pin leakage current specifications.

| Table 9. I/ | 0 Pin Leakage | Current for Stratix | / Devices ⁽¹⁾ |
|-------------|---------------|-----------------------------|--------------------------|
|-------------|---------------|-----------------------------|--------------------------|

| Symbol | Description | Conditions | Min | Тур | Max | Unit |
|-----------------|--------------------|--|-----|-----|-----|------|
| I _I | Input pin | $V_I = 0 V \text{ to } V_{CCIOMAX}$ | -30 | — | 30 | μA |
| I _{0Z} | Tri-stated I/O pin | $V_0 = 0 V \text{ to } V_{\text{CCIOMAX}}$ | -30 | | 30 | μA |

Note to Table 9:

(1) If $V_0 = V_{CCIO}$ to $V_{CCIOMax}$, 100 μ A of leakage current per I/O is expected.

Bus Hold Specifications

Table 10 lists the Stratix V device family bus hold specifications.

Table 10. Bus Hold Parameters for Stratix V Devices

| | | | | V _{CCIO} | | | | | | | | | |
|-------------------------------|-------------------|--|-------|-------------------|-------|------|-------|------|-------|------|-------|------|------|
| Parameter | Symbol | Conditions | 1.2 | 2 V | 1. | 5 V | 1.8 | B V | 2. | 5 V | 3.0 | V | Unit |
| | | | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | |
| Low sustaining current | I _{SUSL} | V _{IN} > V _{IL} (maximum) | 22.5 | _ | 25.0 | _ | 30.0 | _ | 50.0 | _ | 70.0 | _ | μA |
| High sustaining current | I _{SUSH} | V _{IN} < V _{IH} (minimum) | -22.5 | _ | -25.0 | _ | -30.0 | _ | -50.0 | _ | -70.0 | _ | μA |
| Low overdrive current | I _{odl} | $0V < V_{IN} < V_{CCIO}$ | _ | 120 | _ | 160 | _ | 200 | _ | 300 | _ | 500 | μA |
| High overdrive current | I _{odh} | 0V < V _{IN} < V _{CCI0} | | -120 | | -160 | _ | -200 | | -300 | _ | -500 | μA |
| Bus-hold trip point | V _{trip} | _ | 0.45 | 0.95 | 0.50 | 1.00 | 0.68 | 1.07 | 0.70 | 1.70 | 0.80 | 2.00 | V |

On-Chip Termination (OCT) Specifications

If you enable OCT calibration, calibration is automatically performed at power-up for I/Os connected to the calibration block. Table 11 lists the Stratix V OCT termination calibration accuracy specifications.

Table 11. OCT Calibration Accuracy Specifications for Stratix V Devices ⁽¹⁾ (Part 1 of 2)

| | | | | Calibratio | n Accuracy | | |
|---------------------|---|--|-----|------------|----------------|-------|------|
| Symbol | Description | Conditions | C1 | C2,12 | C3,I3, I3YY | C4,14 | Unit |
| 25-Ω R _S | Internal series termination with calibration (25- Ω setting) | V _{CCI0} = 3.0, 2.5, 1.8, 1.5, 1.2 V | ±15 | ±15 | ±15 | ±15 | % |

| Symbol | Description | V _{CCIO} (V) | Typical | Unit |
|--------|--|-----------------------|---------|------|
| | | 3.0 | 0.189 | |
| | OCT variation with temperature without recalibration | 2.5 | 0.208 | |
| dR/dT | | 1.8 | 0.266 | %/°C |
| | | 1.5 | 0.273 | |
| | | 1.2 | 0.317 | |

Table 13. OCT Variation after Power-Up Calibration for Stratix V Devices (Part 2 of 2)⁽¹⁾

Note to Table 13:

(1) Valid for a V_{CCIO} range of $\pm 5\%$ and a temperature range of 0° to 85°C.

Pin Capacitance

Table 14 lists the Stratix V device family pin capacitance.

Table 14. Pin Capacitance for Stratix V Devices

| Symbol Description | | Value | Unit |
|--------------------|--|-------|------|
| C _{IOTB} | Input capacitance on the top and bottom I/O pins | 6 | pF |
| C _{IOLR} | Input capacitance on the left and right I/O pins | 6 | pF |
| C _{OUTFB} | Input capacitance on dual-purpose clock output and feedback pins | 6 | рF |

Hot Socketing

Table 15 lists the hot socketing specifications for Stratix V devices.

| Table 15. | Hot Socketing Specifications for Stratix V Devices |
|-----------|--|
|-----------|--|

| Symbol | Description | Maximum |
|---------------------------|--|---------------------|
| I _{IOPIN (DC)} | DC current per I/O pin | 300 μA |
| I _{IOPIN (AC)} | AC current per I/O pin | 8 mA ⁽¹⁾ |
| I _{XCVR-TX (DC)} | DC current per transceiver transmitter pin | 100 mA |
| I _{XCVR-RX (DC)} | DC current per transceiver receiver pin | 50 mA |

Note to Table 15:

(1) The I/O ramp rate is 10 ns or more. For ramp rates faster than 10 ns, $|I_{10PIN}| = C dv/dt$, in which C is the I/O pin capacitance and dv/dt is the slew rate.

Internal Weak Pull-Up Resistor

Table 16 lists the weak pull-up resistor values for Stratix V devices.

| Symbol | Description | V _{CCIO} Conditions (V) ⁽³⁾ | Value ⁽⁴⁾ | Unit |
|-----------------|---|--|----------------------|------|
| | | 3.0 ±5% | 25 | kΩ |
| | | 2.5 ±5% | 25 | kΩ |
| | Value of the I/O pin pull-up resistor before | 1.8 ±5% | 25 | kΩ |
| R _{PU} | and during configuration, as well as user mode if you enable the programmable | 1.5 ±5% | 25 | kΩ |
| | pull-up resistor option. | 1.35 ±5% | 25 | kΩ |
| | | 1.25 ±5% | 25 | kΩ |
| | | 1.2 ±5% | 25 | kΩ |

Table 16. Internal Weak Pull-Up Resistor for Stratix V Devices (1), (2)

Notes to Table 16:

(1) All I/O pins have an option to enable the weak pull-up resistor except the configuration, test, and JTAG pins.

(2) The internal weak pull-down feature is only available for the JTAG TCK pin. The typical value for this internal weak pull-down resistor is approximately 25 k Ω .

- (3) The pin pull-up resistance values may be lower if an external source drives the pin higher than V_{CCIO}.
- (4) These specifications are valid with a $\pm 10\%$ tolerance to cover changes over PVT.

I/O Standard Specifications

Table 17 through Table 22 list the input voltage (V_{IH} and V_{IL}), output voltage (V_{OH} and V_{OL}), and current drive characteristics (I_{OH} and I_{OL}) for various I/O standards supported by Stratix V devices. These tables also show the Stratix V device family I/O standard specifications. The V_{OL} and V_{OH} values are valid at the corresponding I_{OH} and I_{OL}, respectively.

For an explanation of the terms used in Table 17 through Table 22, refer to "Glossary" on page 65. For tolerance calculations across all SSTL and HSTL I/O standards, refer to Altera knowledge base solution rd07262012_486.

| I/O | | V _{ccio} (V) | | V | L (V) | VIH | (V) | V _{OL} (V) | V _{OH} (V) | IOL | I _{oh} |
|----------|-------|-----------------------|-------|------|-----------------------------|-----------------------------|-------------------------|-----------------------------|-----------------------------|------|-----------------|
| Standard | Min | Тур | Max | Min | Max | Min | Max | Max | Min | (mĀ) | (mÅ) |
| LVTTL | 2.85 | 3 | 3.15 | -0.3 | 0.8 | 1.7 | 3.6 | 0.4 | 2.4 | 2 | -2 |
| LVCMOS | 2.85 | 3 | 3.15 | -0.3 | 0.8 | 1.7 | 3.6 | 0.2 | $V_{CCI0} - 0.2$ | 0.1 | -0.1 |
| 2.5 V | 2.375 | 2.5 | 2.625 | -0.3 | 0.7 | 1.7 | 3.6 | 0.4 | 2 | 1 | -1 |
| 1.8 V | 1.71 | 1.8 | 1.89 | -0.3 | 0.35 * V _{CCI0} | 0.65 * V _{CCI0} | V _{CCI0} + 0.3 | 0.45 | V _{CCI0} – 0.45 | 2 | -2 |
| 1.5 V | 1.425 | 1.5 | 1.575 | -0.3 | 0.35 * V _{CCI0} | 0.65 * V _{CCI0} | V _{CCI0} + 0.3 | 0.25 * V _{CCI0} | 0.75 * V _{CCIO} | 2 | -2 |
| 1.2 V | 1.14 | 1.2 | 1.26 | -0.3 | 0.35 * V _{CCI0} | 0.65 * V _{CCIO} | V _{CCI0} + 0.3 | 0.25 * V _{CCI0} | 0.75 * V _{CCI0} | 2 | -2 |

Table 17. Single-Ended I/O Standards for Stratix V Devices

| I/O Standard | V _{IL(DI} | _{c)} (V) | V _{IH(D} | _{C)} (V) | V _{IL(AC)} (V) | V _{IH(AC)} (V) | V _{ol} (V) | V _{oh} (V) | I (mA) | I _{oh} |
|---------------------|--------------------|----------------------------|----------------------------|-----------------------------|----------------------------|-------------------------|----------------------------|----------------------------|----------------------|-----------------|
| i/U Stanuaru | Min | Max | Min | Max | Max | Min | Max | Min | l _{oi} (mA) | (mA) |
| HSTL-18 Class I | _ | V _{REF} – 0.1 | V _{REF} + 0.1 | _ | $V_{REF} - 0.2$ | V _{REF} + 0.2 | 0.4 | V _{CCIO} – 0.4 | 8 | -8 |
| HSTL-18 Class II | _ | V _{REF} – 0.1 | V _{REF} + 0.1 | _ | V _{REF} - 0.2 | V _{REF} + 0.2 | 0.4 | V _{CCIO} – 0.4 | 16 | -16 |
| HSTL-15 Class I | _ | V _{REF} – 0.1 | V _{REF} + 0.1 | _ | V _{REF} - 0.2 | V _{REF} + 0.2 | 0.4 | V _{CCIO} – 0.4 | 8 | -8 |
| HSTL-15 Class II | _ | V _{REF} – 0.1 | V _{REF} + 0.1 | _ | V _{REF} - 0.2 | V _{REF} + 0.2 | 0.4 | V _{CCIO} – 0.4 | 16 | -16 |
| HSTL-12 Class I | -0.15 | V _{REF} – 0.08 | V _{REF} + 0.08 | V _{CCIO} + 0.15 | V _{REF} – 0.15 | V _{REF} + 0.15 | 0.25* V _{CCI0} | 0.75* V _{CCI0} | 8 | -8 |
| HSTL-12 Class II | -0.15 | V _{REF} – 0.08 | V _{REF} + 0.08 | V _{CCIO} + 0.15 | V _{REF} – 0.15 | V _{REF} + 0.15 | 0.25* V _{CCIO} | 0.75* V _{CCI0} | 16 | -16 |
| HSUL-12 | _ | V _{REF} – 0.13 | V _{REF} + 0.13 | _ | V _{REF} – 0.22 | V _{REF} + 0.22 | 0.1* V _{CCIO} | 0.9* V _{CCI0} | _ | _ |

Table 19. Single-Ended SSTL, HSTL, and HSUL I/O Standards Signal Specifications for Stratix V Devices (Part 2 of 2)

Table 20. Differential SSTL I/O Standards for Stratix V Devices

| I/O Standard | | V _{ccio} (V) | | V _{SWIN} | V _{SWING(DC)} (V) V _{X(AC)} (V) | | | | V _{SWING(AC)} (V) | | |
|-------------------------|-------|-----------------------|-------|-------------------|---|--------------------------------|----------------------|---------------------------------|---|---|--|
| ijo Stanuaru | Min | Тур | Max | Min | Max | Min | Тур | Max | Min | Max | |
| SSTL-2 Class I, II | 2.375 | 2.5 | 2.625 | 0.3 | V _{CCI0} + 0.6 | V _{CCI0} /2- 0.2 | _ | V _{CCI0} /2 + 0.2 | 0.62 | V _{CCI0} + 0.6 | |
| SSTL-18 Class I, II | 1.71 | 1.8 | 1.89 | 0.25 | V _{CCI0} + 0.6 | V _{CCI0} /2- 0.175 | _ | V _{CCI0} /2 + 0.175 | 0.5 | V _{CCI0} + 0.6 | |
| SSTL-15 Class I, II | 1.425 | 1.5 | 1.575 | 0.2 | (1) | V _{CCI0} /2- 0.15 | _ | V _{CCI0} /2 + 0.15 | 0.35 | _ | |
| SSTL-135 Class I, II | 1.283 | 1.35 | 1.45 | 0.2 | (1) | V _{CCI0} /2- 0.15 | V _{CCI0} /2 | V _{CCI0} /2 + 0.15 | 2(V _{IH(AC)} - V _{REF}) | 2(V _{IL(AC)} - V _{REF}) | |
| SSTL-125 Class I, II | 1.19 | 1.25 | 1.31 | 0.18 | (1) | V _{CCI0} /2- 0.15 | V _{CCI0} /2 | V _{CCI0} /2 + 0.15 | 2(V _{IH(AC)} - V _{REF}) | _ | |
| SSTL-12 Class I, II | 1.14 | 1.2 | 1.26 | 0.18 | _ | V _{REF} -0.15 | V _{CCI0} /2 | V _{REF} + 0.15 | -0.30 | 0.30 | |

Note to Table 20:

(1) The maximum value for $V_{SWING(DC)}$ is not defined. However, each single-ended signal needs to be within the respective single-ended limits $(V_{IH(DC)} \text{ and } V_{IL(DC)})$.

| I/O | | V _{ccio} (V) | | V _{DIF(I} | _{C)} (V) V _{X(AC)} (V) | | | V _{CM(DC)} (V | V _{DIF(AC)} (V) | | | | |
|------------------------|-------|-----------------------|-------|--------------------|--|------|-----|------------------------|--------------------------|-----|------|-----|-----|
| Standard | Min | Тур | Max | Min | Max | Min | Тур | Max | Min | Тур | Max | Min | Max |
| HSTL-18 Class I, II | 1.71 | 1.8 | 1.89 | 0.2 | _ | 0.78 | _ | 1.12 | 0.78 | _ | 1.12 | 0.4 | _ |
| HSTL-15 Class I, II | 1.425 | 1.5 | 1.575 | 0.2 | _ | 0.68 | _ | 0.9 | 0.68 | _ | 0.9 | 0.4 | _ |

| Table 28. Transceiver Specifications for Stratix V GT Devices (Part 4 of 5) ⁽¹⁾ |
|--|
|--|

| Symbol/ | Conditions | | Transceive peed Grade | | | Fransceive Deed Grade | | Unit | | |
|--|--|--------|--------------------------|--------------------------------|--------|--------------------------|--------------------------------|------|--|--|
| Description | | Min | Тур | Max | Min | Тур | Max | | | |
| Data rate | GT channels | 19,600 | | 28,050 | 19,600 | | 25,780 | Mbps | | |
| Differential on-chip | GT channels | | 100 | _ | | 100 | | Ω | | |
| termination resistors | GX channels | | 1 | 1 | (8) | | 11 | | | |
| | GT channels | | 500 | _ | | 500 | — | mV | | |
| V_{OCM} (AC coupled) | GX channels | | 1 | 1 | (8) | | 11 | | | |
| Dies/Fall times | GT channels | _ | 15 | _ | | 15 | — | ps | | |
| Rise/Fall time | GX channels | | | | (8) | | 1 | | | |
| Intra-differential pair skew | GX channels | | | | (8) | | | | | |
| Intra-transceiver block transmitter channel-to- channel skew | GX channels | | (8) | | | | | | | |
| Inter-transceiver block transmitter channel-to- channel skew | GX channels | | | | (8) | | | | | |
| CMU PLL | · · · · · · | | | | | | | | | |
| Supported Data Range | — | 600 | — | 12500 | 600 | — | 8500 | Mbps | | |
| t _{pll_powerdown} (13) | — | 1 | — | — | 1 | _ | — | μs | | |
| t _{pll_lock} ⁽¹⁴⁾ | — | _ | — | 10 | — | _ | 10 | μs | | |
| ATX PLL | | | | | | | | | | |
| | VCO post- divider L=2 | 8000 | _ | 12500 | 8000 | _ | 8500 | Mbps | | |
| | L=4 | 4000 | — | 6600 | 4000 | _ | 6600 | Mbps | | |
| Supported Data Rate | L=8 | 2000 | — | 3300 | 2000 | - | 3300 | Mbps | | |
| Range for GX Channels | L=8, Local/Central Clock Divider =2 | 1000 | _ | 1762.5 | 1000 | _ | 1762.5 | Mbps | | |
| Supported Data Rate Range for GT Channels | VCO post- divider L=2 | 9800 | _ | 14025 | 9800 | _ | 12890 | Mbps | | |
| t _{pll_powerdown} ⁽¹³⁾ | — | 1 | — | — | 1 | — | — | μs | | |
| t _{pll_lock} ⁽¹⁴⁾ | — | | — | 10 | — | — | 10 | μs | | |
| fPLL | | | | | | - | · · | | | |
| Supported Data Range | _ | 600 | | 3250/ 3.125 ⁽²³⁾ | 600 | _ | 3250/ 3.125 ⁽²³⁾ | Mbps | | |
| t _{pll_powerdown} (13) | | 1 | _ | | 1 | | | μs | | |

Table 29 shows the V_{OD} settings for the GT channel.

| Table 29. | Typical Von Setting | g for GT Channel, T | EX Termination = 100 Ω |
|-----------|---------------------|---------------------|--------------------------------------|
|-----------|---------------------|---------------------|--------------------------------------|

| Symbol | V _{OD} Setting | V _{op} Value (mV) |
|---|-------------------------|----------------------------|
| | 0 | 0 |
| | 1 | 200 |
| \mathbf{V}_{0D} differential peak to peak typical (1) | 2 | 400 |
| VOD unicicilitat peak to peak typical (*) | 3 | 600 |
| | 4 | 800 |
| | 5 | 1000 |

Note:

(1) Refer to Figure 4.

- XFI
- ASI
- HiGig/HiGig+
- HiGig2/HiGig2+
- Serial Data Converter (SDC)
- GPON
- SDI
- SONET
- Fibre Channel (FC)
- PCIe
- QPI
- SFF-8431

Download the Stratix V Characterization Report Tool to view the characterization report summary for these protocols.

Core Performance Specifications

This section describes the clock tree, phase-locked loop (PLL), digital signal processing (DSP), memory blocks, configuration, and JTAG specifications.

Clock Tree Specifications

Table 30 lists the clock tree specifications for Stratix V devices.

Table 30. Clock Tree Performance for Stratix V Devices (1)

| | | Performance | | |
|------------------------------|-----------------------------|--------------------------|--------|------|
| Symbol | C1, C2, C2L, I2, and I2L | C3, I3, I3L, and I3YY | C4, I4 | Unit |
| Global and Regional Clock | 717 | 650 | 580 | MHz |
| Periphery Clock | 550 | 500 | 500 | MHz |

Note to Table 30:

(1) The Stratix V ES devices are limited to 600 MHz core clock tree performance.

| Peformance | | | | | | | | | |
|------------------------|-----|---------|---------|-----|------------------|-----|-----|------|--|
| Mode | C1 | C2, C2L | 12, 12L | C3 | 13, 13L, 13YY | C4 | 14 | Unit | |
| Modes using Three DSPs | | | | | | | | | |
| One complex 18 x 25 | 425 | 425 | 415 | 340 | 340 | 275 | 265 | MHz | |
| Modes using Four DSPs | | | | | | | | | |
| One complex 27 x 27 | 465 | 465 | 465 | 380 | 380 | 300 | 290 | MHz | |

Table 32. Block Performance Specifications for Stratix V DSP Devices (Part 2 of 2)

Memory Block Specifications

Table 33 lists the Stratix V memory block specifications.

Table 33. Memory Block Performance Specifications for Stratix V Devices ^{(1), (2)} (Part 1 of 2)

| | | Resources Used | | Performance | | | | | | | |
|--------|--|-----------------------|--------|-------------|------------|-----|-----|---------|---------------------|-----|------|
| Memory | Mode | ALUTS | Memory | C1 | C2, C2L | C3 | C4 | 12, 12L | 13, 13L, 13YY | 14 | Unit |
| | Single port, all supported widths | 0 | 1 | 450 | 450 | 400 | 315 | 450 | 400 | 315 | MHz |
| MLAB | Simple dual-port, x32/x64 depth | 0 | 1 | 450 | 450 | 400 | 315 | 450 | 400 | 315 | MHz |
| IVILAD | Simple dual-port, x16 depth ⁽³⁾ | 0 | 1 | 675 | 675 | 533 | 400 | 675 | 533 | 400 | MHz |
| | ROM, all supported widths | 0 | 1 | 600 | 600 | 500 | 450 | 600 | 500 | 450 | MHz |

| 0h.a.l | Oanditiana | C1 | | | C2, C2L, I2, I2L | | C3, I3, I3L, I3YY | | C4,14 | | | Unit | | |
|---|--|-----|-----|------|------------------|-----|-------------------|-----|-------|------|-----|------|------|-------|
| Symbol | Conditions | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | UIIIL |
| Transmitter | • | | | | | | | | | | | | | • |
| | SERDES factor J = 3 to 10 (9), (11), (12), (13), (14), (15), (16) | (6) | _ | 1600 | (6) | _ | 1434 | (6) | _ | 1250 | (6) | _ | 1050 | Mbps |
| | $\begin{array}{c} \text{SERDES factor J} \\ \geq 4 \end{array}$ | | | | | | | | | | | | | |
| True Differential I/O Standards | LVDS TX with DPA ⁽¹²⁾ , ⁽¹⁴⁾ , ⁽¹⁵⁾ , ⁽¹⁶⁾ | (6) | | 1600 | (6) | | 1600 | (6) | _ | 1600 | (6) | _ | 1250 | Mbps |
| - f _{HSDR} (data rate) | SERDES factor J = 2, | (6) | | (7) | (6) | | (7) | (6) | | (7) | (6) | | (7) | Mbps |
| | uses DDR Registers | (0) | _ | (7) | (0) | | (7) | (0) | _ | (7) | (0) | _ | (7) | wups |
| | SERDES factor J = 1, uses SDR Register | (6) | _ | (7) | (6) | _ | (7) | (6) | | (7) | (6) | | (7) | Mbps |
| Emulated Differential I/O Standards with Three External Output Resistor Networks - f _{HSDR} (data rate) ⁽¹⁰⁾ | SERDES factor J = 4 to 10 (17) | (6) | | 1100 | (6) | | 1100 | (6) | | 840 | (6) | | 840 | Mbps |
| t _{x Jitter} - True Differential | Total Jitter for Data Rate 600 Mbps - 1.25 Gbps | _ | _ | 160 | _ | _ | 160 | | | 160 | _ | | 160 | ps |
| I/O Standards | Total Jitter for Data Rate < 600 Mbps | _ | _ | 0.1 | _ | _ | 0.1 | _ | _ | 0.1 | _ | _ | 0.1 | UI |
| t _{x Jitter} - Emulated Differential I/O Standards | Total Jitter for Data Rate 600 Mbps - 1.25 Gbps | _ | _ | 300 | _ | _ | 300 | _ | _ | 300 | _ | _ | 325 | ps |
| with Three External Output Resistor Network | Total Jitter for Data Rate < 600 Mbps | _ | | 0.2 | | | 0.2 | | | 0.2 | _ | | 0.25 | UI |

Table 36. High-Speed I/O Specifications for Stratix V Devices (1), (2) (Part 2 of 4)

| Speed Grade | Min | Max | Unit |
|-------------|-----|-----|------|
| C4,I4 | 8 | 16 | ps |

Table 40. DQS Phase Offset Delay Per Setting for Stratix V Devices ^{(1), (2)} (Part 2 of 2)

Notes to Table 40:

(1) The typical value equals the average of the minimum and maximum values.

(2) The delay settings are linear with a cumulative delay variation of 40 ps for all speed grades. For example, when using a -2 speed grade and applying a 10-phase offset setting to a 90° phase shift at 400 MHz, the expected average cumulative delay is [625 ps + (10 × 10 ps) ± 20 ps] = 725 ps ± 20 ps.

Table 41 lists the DQS phase shift error for Stratix V devices.

Table 41. DQS Phase Shift Error Specification for DLL-Delayed Clock (t_{DQS_PSERR}) for Stratix V Devices ⁽¹⁾

| Number of DQS Delay Buffers | C1 | C2, C2L, I2, I2L | C3, I3, I3L, I3YY | C4,14 | Unit |
|--------------------------------|-----|------------------|-------------------|-------|------|
| 1 | 28 | 28 | 30 | 32 | ps |
| 2 | 56 | 56 | 60 | 64 | ps |
| 3 | 84 | 84 | 90 | 96 | ps |
| 4 | 112 | 112 | 120 | 128 | ps |

Notes to Table 41:

(1) This error specification is the absolute maximum and minimum error. For example, skew on three DQS delay buffers in a -2 speed grade is ± 78 ps or ± 39 ps.

Table 42 lists the memory output clock jitter specifications for Stratix V devices.

| Clock Network | Parameter | Symbol | C1 | | C2, C2L, I2, I2L | | C3, I3, I3L, I3YY | | C4,I4 | | Unit |
|------------------|---------------------------------|-----------------------|------|-----|------------------|-----|----------------------|------|-------|------|------|
| NELWUIK | NELWORK | | Min | Max | Min | Max | Min | Max | Min | Max | |
| | Clock period jitter | t _{JIT(per)} | -50 | 50 | -50 | 50 | -55 | 55 | -55 | 55 | ps |
| Regional | Cycle-to-cycle period jitter | $t_{\rm JIT(cc)}$ | -100 | 100 | -100 | 100 | -110 | 110 | -110 | 110 | ps |
| | Duty cycle jitter | $t_{JIT(duty)}$ | -50 | 50 | -50 | 50 | -82.5 | 82.5 | -82.5 | 82.5 | ps |
| | Clock period jitter | t _{JIT(per)} | -75 | 75 | -75 | 75 | -82.5 | 82.5 | -82.5 | 82.5 | ps |
| Global | Cycle-to-cycle period jitter | $t_{\text{JIT(cc)}}$ | -150 | 150 | -150 | 150 | -165 | 165 | -165 | 165 | ps |
| | Duty cycle jitter | $t_{JIT(duty)}$ | -75 | 75 | -75 | 75 | -90 | 90 | -90 | 90 | ps |

Duty Cycle Distortion (DCD) Specifications

Table 44 lists the worst-case DCD for Stratix V devices.

Table 44. Worst-Case DCD on Stratix V I/O Pins (1)

| Symbol | C | 1 | C2, C2 | L, 12, 12L | | 3, I3L, Syy | C4 | 4,14 | Unit |
|-------------------|-----|-----|--------|------------|-----|----------------|-----|------|------|
| | Min | Max | Min | Max | Min | Max | Min | Max | |
| Output Duty Cycle | 45 | 55 | 45 | 55 | 45 | 55 | 45 | 55 | % |

Note to Table 44:

(1) The DCD numbers do not cover the core clock network.

Configuration Specification

POR Delay Specification

Power-on reset (POR) delay is defined as the delay between the time when all the power supplies monitored by the POR circuitry reach the minimum recommended operating voltage to the time when the nSTATUS is released high and your device is ready to begin configuration.



For more information about the POR delay, refer to the *Hot Socketing and Power-On Reset in Stratix V Devices* chapter.

Table 45 lists the fast and standard POR delay specification.

Table 45. Fast and Standard POR Delay Specification (1)

| POR Delay | Minimum | Maximum |
|-----------|---------|---------|
| Fast | 4 ms | 12 ms |
| Standard | 100 ms | 300 ms |

Note to Table 45:

(1) You can select the POR delay based on the MSEL settings as described in the MSEL Pin Settings section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices" chapter.

JTAG Configuration Specifications

Table 46 lists the JTAG timing parameters and values for Stratix V devices.

Table 46. JTAG Timing Parameters and Values for Stratix V Devices

| Symbol | Description | Min | Max | Unit |
|-------------------------|------------------------------------|-----|-----|------|
| t _{JCP} | TCK clock period ⁽²⁾ | 30 | — | ns |
| t _{JCP} | TCK clock period ⁽²⁾ | 167 | — | ns |
| t _{JCH} | TCK clock high time ⁽²⁾ | 14 | — | ns |
| t _{JCL} | TCK clock low time ⁽²⁾ | 14 | — | ns |
| t _{JPSU (TDI)} | TDI JTAG port setup time | 2 | — | ns |
| t _{JPSU (TMS)} | TMS JTAG port setup time | 3 | — | ns |

| Symbol | Description | Min | Max | Unit |
|-------------------|--|-----|---------------------------|------|
| t _{JPH} | JTAG port hold time | 5 | — | ns |
| t _{JPCO} | JTAG port clock to output | — | 11 ⁽¹⁾ | ns |
| t _{JPZX} | JTAG port high impedance to valid output | — | 14 ⁽¹⁾ | ns |
| t _{JPXZ} | JTAG port valid output to high impedance | — | 1 4 ⁽¹⁾ | ns |

Table 46. JTAG Timing Parameters and Values for Stratix V Devices

Notes to Table 46:

(1) A 1 ns adder is required for each V_{CCI0} voltage step down from 3.0 V. For example, $t_{JPC0} = 12$ ns if V_{CCI0} of the TDO I/O bank = 2.5 V, or 13 ns if it equals 1.8 V.

(2) The minimum TCK clock period is 167 ns if VCCBAT is within the range 1.2V-1.5V when you perform the volatile key programming.

Raw Binary File Size

For the POR delay specification, refer to the "POR Delay Specification" section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices".

Table 47 lists the uncompressed raw binary file (.rbf) sizes for Stratix V devices.

| Family | Device | Package | Configuration .rbf Size (bits) | IOCSR .rbf Size (bits) ^{(4), (5)} |
|--------------|--------|------------------------------|--------------------------------|--|
| | ECCVA0 | H35, F40, F35 ⁽²⁾ | 213,798,880 | 562,392 |
| | 5SGXA3 | H29, F35 ⁽³⁾ | 137,598,880 | 564,504 |
| | 5SGXA4 | _ | 213,798,880 | 563,672 |
| | 5SGXA5 | _ | 269,979,008 | 562,392 |
| Stratix V GX | 5SGXA7 | _ | 269,979,008 | 562,392 |
| | 5SGXA9 | _ | 342,742,976 | 700,888 |
| | 5SGXAB | _ | 342,742,976 | 700,888 |
| | 5SGXB5 | _ | 270,528,640 | 584,344 |
| | 5SGXB6 | _ | 270,528,640 | 584,344 |
| | 5SGXB9 | _ | 342,742,976 | 700,888 |
| | 5SGXBB | _ | 342,742,976 | 700,888 |
| Stratix V GT | 5SGTC5 | _ | 269,979,008 | 562,392 |
| | 5SGTC7 | — | 269,979,008 | 562,392 |
| | 5SGSD3 | _ | 137,598,880 | 564,504 |
| | 5SGSD4 | F1517 | 213,798,880 | 563,672 |
| Ctratic V CC | 556504 | _ | 137,598,880 | 564,504 |
| Stratix V GS | 5SGSD5 | _ | 213,798,880 | 563,672 |
| | 5SGSD6 | _ | 293,441,888 | 565,528 |
| | 5SGSD8 | — | 293,441,888 | 565,528 |

Table 47. Uncompressed .rbf Sizes for Stratix V Devices

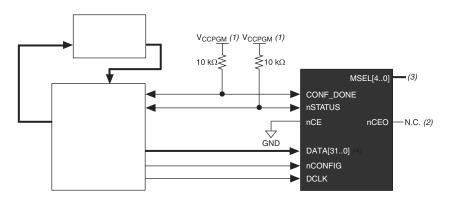
| Configuration Scheme | Decompression | Design Security | DCLK-to-DATA[] Ratio |
|-------------------------|---------------|-----------------|-------------------------|
| | Disabled | Disabled | 1 |
| FPP ×32 | Disabled | Enabled | 4 |
| FFF X02 | Enabled | Disabled | 8 |
| | Enabled | Enabled | 8 |

Note to Table 49:

(1) Depending on the DCLK-to-DATA [] ratio, the host must send a DCLK frequency that is r times the data rate in bytes per second (Bps), or words per second (Wps). For example, in FPP ×16 when the DCLK-to-DATA [] ratio is 2, the DCLK frequency must be 2 times the data rate in Wps. Stratix V devices use the additional clock cycles to decrypt and decompress the configuration data.

Figure 11 shows the configuration interface connections between the Stratix V device and a MAX II or MAX V device for single device configuration.

Figure 11. Single Device FPP Configuration Using an External Host



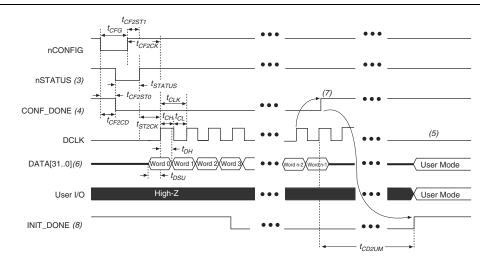
Notes to Figure 11:

- (1) Connect the resistor to a supply that provides an acceptable input signal for the Stratix V device. V_{CCPGM} must be high enough to meet the V_{IH} specification of the I/O on the device and the external host. Altera recommends powering up all configuration system I/Os with V_{CCPGM} .
- (2) You can leave the nCEO pin unconnected or use it as a user I/O pin when it does not feed another device's nCE pin.
- (3) The MSEL pin settings vary for different data width, configuration voltage standards, and POR delay. To connect MSEL, refer to the MSEL Pin Settings section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices" chapter.
- (4) If you use FPP ×8, use DATA [7..0]. If you use FPP ×16, use DATA [15..0].

IF the DCLK-to-DATA[] ratio is greater than 1, at the end of configuration, you can only stop the DCLK (DCLK-to-DATA[] ratio – 1) clock cycles after the last data is latched into the Stratix V device.

FPP Configuration Timing when DCLK-to-DATA [] = 1

Figure 12 shows the timing waveform for FPP configuration when using a MAX II or MAX V device as an external host. This waveform shows timing when the DCLK-to-DATA[] ratio is 1.





Notes to Figure 12:

- (1) Use this timing waveform when the DCLK-to-DATA [] ratio is 1.
- (2) The beginning of this waveform shows the device in user mode. In user mode, nCONFIG, nSTATUS, and CONF_DONE are at logic-high levels. When nCONFIG is pulled low, a reconfiguration cycle begins.
- (3) After power-up, the Stratix V device holds nstatus low for the time of the POR delay.
- (4) After power-up, before and during configuration, CONF_DONE is low.
- (5) Do not leave DCLK floating after configuration. DCLK is ignored after configuration is complete. It can toggle high or low if required.
- (6) For FPP ×16, use DATA [15..0]. For FPP ×8, use DATA [7..0]. DATA [31..0] are available as a user I/O pin after configuration. The state of this pin depends on the dual-purpose pin settings.
- (7) To ensure a successful configuration, send the entire configuration data to the Stratix V device. CONF_DONE is released high when the Stratix V device receives all the configuration data successfully. After CONF_DONE goes high, send two additional falling edges on DCLK to begin initialization and enter user mode.
- (8) After the option bit to enable the INIT_DONE pin is configured into the device, the INIT DONE goes low.

| Symbol | Parameter | Minimum | Maximum | Units |
|---------------------|---|--|---------|-------|
| t _{CD2UM} | CONF_DONE high to user mode (3) | 175 | 437 | μS |
| t _{CD2CU} | CONF_DONE high to CLKUSR enabled | 4 × maximum DCLK period | _ | — |
| t _{CD2UMC} | CONF_DONE high to user mode with CLKUSR option on | t _{cd2cu} + (8576 × clkusr period) | _ | — |

Table 53. AS Timing Parameters for AS \times 1 and AS \times 4 Configurations in Stratix V Devices ^{(1), (2)} (Part 2 of 2)

Notes to Table 53:

(1) The minimum and maximum numbers apply only if you choose the internal oscillator as the clock source for initializing the device.

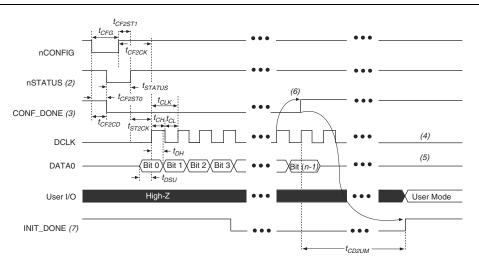
(2) t_{CF2CD}, t_{CF2ST0}, t_{CF2ST0}, t_{CF6}, t_{STATUS}, and t_{CF2ST1} timing parameters are identical to the timing parameters for PS mode listed in Table 54 on page 63.

(3) To enable the CLKUSR pin as the initialization clock source and to obtain the maximum frequency specification on this pin, refer to the Initialization section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices" chapter.

Passive Serial Configuration Timing

Figure 15 shows the timing waveform for a passive serial (PS) configuration when using a MAX II device, MAX V device, or microprocessor as an external host.

Figure 15. PS Configuration Timing Waveform ⁽¹⁾



Notes to Figure 15:

- (1) The beginning of this waveform shows the device in user mode. In user mode, nCONFIG, nSTATUS, and CONF_DONE are at logic high levels. When nCONFIG is pulled low, a reconfiguration cycle begins.
- (2) After power-up, the Stratix V device holds <code>nSTATUS</code> low for the time of the POR delay.
- (3) After power-up, before and during configuration, CONF DONE is low.
- (4) Do not leave DCLK floating after configuration. You can drive it high or low, whichever is more convenient.
- (5) DATAO is available as a user I/O pin after configuration. The state of this pin depends on the dual-purpose pin settings in the **Device and Pins Option**.
- (6) To ensure a successful configuration, send the entire configuration data to the Stratix V device. CONF_DONE is released high after the Stratix V device receives all the configuration data successfully. After CONF_DONE goes high, send two additional falling edges on DCLK to begin initialization and enter user mode.
- (7) After the option bit to enable the INIT DONE pin is configured into the device, the INIT DONE goes low.

Remote System Upgrades

Table 56 lists the timing parameter specifications for the remote system upgrade circuitry.

| Table 56. Remote System Upgrade Circuitry Timing Specifications |
|---|
|---|

| Parameter | Minimum | Maximum | Unit | | |
|---|---------|---------|------|--|--|
| t _{RU_nCONFIG} ⁽¹⁾ | 250 | — | ns | | |
| t _{RU_nRSTIMER} ⁽²⁾ | 250 | _ | ns | | |

Notes to Table 56:

- (1) This is equivalent to strobing the reconfiguration input of the ALTREMOTE_UPDATE megafunction high for the minimum timing specification. For more information, refer to the Remote System Upgrade State Machine section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices" chapter.
- (2) This is equivalent to strobing the reset_timer input of the ALTREMOTE_UPDATE megafunction high for the minimum timing specification. For more information, refer to the User Watchdog Timer section of the "Configuration, Design Security, and Remote System Upgrades in Stratix V Devices" chapter.

User Watchdog Internal Circuitry Timing Specification

Table 57 lists the operating range of the 12.5-MHz internal oscillator.

Table 57. 12.5-MHz Internal Oscillator Specifications

| Minimum | Typical | Maximum | Units | | |
|---------|---------|---------|-------|--|--|
| 5.3 | 7.9 | 12.5 | MHz | | |

I/O Timing

Altera offers two ways to determine I/O timing—the Excel-based I/O Timing and the Quartus II Timing Analyzer.

Excel-based I/O timing provides pin timing performance for each device density and speed grade. The data is typically used prior to designing the FPGA to get an estimate of the timing budget as part of the link timing analysis. The Quartus II Timing Analyzer provides a more accurate and precise I/O timing data based on the specifics of the design after you complete place-and-route.

 You can download the Excel-based I/O Timing spreadsheet from the Stratix V Devices Documentation web page.

Programmable IOE Delay

Table 58 lists the Stratix V IOE programmable delay settings.

Table 58. IOE Programmable Delay for Stratix V Devices (Part 1 of 2)

| Parameter | Available | Min | Fast | Model | | | | Slow N | lodel | | | |
|-----------|-----------------------|---------------|------------|------------|-------|-------|-------|--------|-------|-------------|-------|------|
| (1) | Available Settings | Offset (2) | Industrial | Commercial | C1 | C2 | C3 | C4 | 12 | 13, 13YY | 14 | Unit |
| D1 | 64 | 0 | 0.464 | 0.493 | 0.838 | 0.838 | 0.924 | 1.011 | 0.844 | 0.921 | 1.006 | ns |
| D2 | 32 | 0 | 0.230 | 0.244 | 0.415 | 0.415 | 0.459 | 0.503 | 0.417 | 0.456 | 0.500 | ns |

Table 61. Document Revision History (Part 2 of 3)

| Date | Version | Changes | | | | | |
|---------------|---------|---|--|--|--|--|--|
| | | Added the I3YY speed grade and changed the data rates for the GX channel in Table 1. | | | | | |
| | | Added the I3YY speed grade to the V_{CC} description in Table 6. | | | | | |
| | | Added the I3YY speed grade to V_{CCHIP_L}, V_{CCHIP_R}, V_{CCHSSI_L}, and V_{CCHSSI_R} descriptions in Table 7. | | | | | |
| | | ■ Added 240-Ω to Table 11. | | | | | |
| | | Changed CDR PPM tolerance in Table 23. | | | | | |
| | | Added additional max data rate for fPLL in Table 23. | | | | | |
| | | Added the I3YY speed grade and changed the data rates for transceiver speed grade 3 in Table 25. | | | | | |
| | | Added the I3YY speed grade and changed the data rates for transceiver speed grade 3 in Table 26. | | | | | |
| | | Changed CDR PPM tolerance in Table 28. | | | | | |
| | 3.3 | Added additional max data rate for fPLL in Table 28. | | | | | |
| | | Changed the mode descriptions for MLAB and M20K in Table 33. | | | | | |
| | | ■ Changed the Max value of f _{HSCLK_OUT} for the C2, C2L, I2, I2L speed grades in Table 36. | | | | | |
| November 2014 | | Changed the frequency ranges for C1 and C2 in Table 39. | | | | | |
| | | Changed the .rbf file sizes for 5SGSD6 and 5SGSD8 in Table 47. | | | | | |
| | | Added note about nSTATUS to Table 50, Table 51, Table 54. | | | | | |
| | | Changed the available settings in Table 58. | | | | | |
| | | Changed the note in "Periphery Performance". | | | | | |
| | | Updated the "I/O Standard Specifications" section. | | | | | |
| | | Updated the "Raw Binary File Size" section. | | | | | |
| | | Updated the receiver voltage input range in Table 22. | | | | | |
| | | Updated the max frequency for the LVDS clock network in Table 36. | | | | | |
| | | ■ Updated the DCLK note to Figure 11. | | | | | |
| | | Updated Table 23 VO_{CM} (DC Coupled) condition. | | | | | |
| | | Updated Table 6 and Table 7. | | | | | |
| | | ■ Added the DCLK specification to Table 55. | | | | | |
| | | Updated the notes for Table 47. | | | | | |
| | | Updated the list of parameters for Table 56. | | | | | |
| November 2013 | 3.2 | Updated Table 28 | | | | | |
| November 2013 | 3.1 | Updated Table 33 | | | | | |
| November 2013 | 3.0 | Updated Table 23 and Table 28 | | | | | |
| October 2013 | 2.9 | Updated the "Transceiver Characterization" section | | | | | |
| | | Updated Table 3, Table 12, Table 14, Table 19, Table 20, Table 23, Table 24, Table 28, Table 30, Table 31, Table 32, Table 33, Table 36, Table 39, Table 40, Table 41, Table 42, Table 47, Table 53, Table 58, and Table 59 | | | | | |
| October 2013 | 2.8 | Added Figure 1 and Figure 3 | | | | | |
| | | Added the "Transceiver Characterization" section | | | | | |
| | | Removed all "Preliminary" designations. | | | | | |